



Preliminary data

**SPP20N60S5**  
**SPB20N60S5**

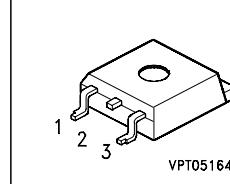

## Cool MOS™ Power Transistor

- New revolutionary high voltage technology
  - Worldwide best  $R_{DS(on)}$  in TO 220
  - Ultra low gate charge
  - Improved periodic avalanche rating
  - Extreme dv/dt rated
  - Optimized capacitances
  - Improved noise immunity
  - Former development designation:
- SPPx1N60S5/SPBx1N60S5

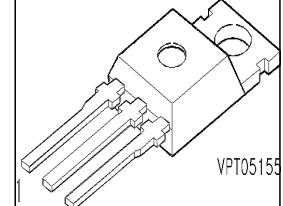
### Product Summary

$V_{DS} @ T_{jmax}$	650	V
$R_{DS(on)}$	0.19	$\Omega$
$I_D$	20	A

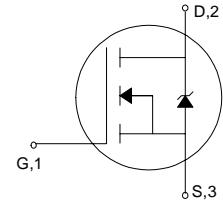
P-TO263-3-2



P-TO220-3-1



Type	Package	Ordering Code	Marking
SPP20N60S5	P-TO220-3-1	Q67040-S4751	20N60S5
SPB20N60S5	P-TO263-3-2	Q67040-S4171	20N60S5



**Maximum Ratings**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_C=25^\circ\text{C}$	$I_D$	20	A
$T_C=100^\circ\text{C}$		13	
Pulsed drain current <sup>1)</sup> $T_C=25^\circ\text{C}$	$I_{D \text{ puls}}$	40	
Avalanche energy, single pulse $I_D = 10 \text{ A}, V_{DD} = 50 \text{ V}$	$E_{AS}$	690	mJ
Avalanche energy (repetitive, limited by $T_{jmax}$ ) $I_D = 20 \text{ A}, V_{DD} = 50 \text{ V}$	$E_{AR}$	1	
Avalanche current (repetitive, limited by $T_{jmax}$ )	$I_{AR}$	20	A
Reverse diode dv/dt $I_S=20\text{A}, V_{DS}<V_{DSS}, dI/dt=100\text{A}/\mu\text{s}, T_{jmax}=150^\circ\text{C}$	dv/dt	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C=25^\circ\text{C}$	$P_{tot}$	208	W
Operating and storage temperature	$T_j, T_{stg}$	-55... +150	°C

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Thermal Characteristics</b>					
Thermal resistance, junction - case	$R_{\text{thJC}}$	-	-	0.6	K/W
Thermal resistance, junction - ambient (Leaded and through-hole packages)	$R_{\text{thJA}}$	-	-	62	
SMD version, device on PCB: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>2)</sup>	$R_{\text{thJA}}$	-	-	62	
		-	35	-	

**Static Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Drain-source breakdown voltage $V_{GS} = 0 \text{ V}$ , $I_D = 0.25 \text{ mA}$	$V_{(\text{BR})\text{DSS}}$	600	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 1 \text{ mA}$ , $T_j = 25^\circ\text{C}$	$V_{GS(\text{th})}$	3.5	4.5	5.5	
Zero gate voltage drain current, $V_{DS}=V_{DSS}$ $V_{GS} = 0 \text{ V}$ , $T_j = 25^\circ\text{C}$ $V_{GS} = 0 \text{ V}$ , $T_j = 150^\circ\text{C}$	$I_{\text{DSS}}$	-	0.5	25	$\mu\text{A}$
-	-	-	-	250	
Gate-source leakage current $V_{GS} = 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	$I_{GSS}$	-	-	100	nA
Drain-source on-state resistance $V_{GS} = 10 \text{ V}$ , $I_D = 13 \text{ A}$	$R_{\text{DS}(\text{on})}$	-	0.16	0.19	$\Omega$

<sup>1</sup>current limited by  $T_{j\text{max}}$ 
<sup>2</sup> Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Dynamic Characteristics</b>						
Transconductance	$g_{fs}$	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 13\text{A}$	-	12	-	S
Input capacitance	$C_{iss}$	$V_{GS}=0\text{V}$ , $V_{DS}=25\text{V}$ , $f=1\text{MHz}$	-	3000	-	pF
Output capacitance	$C_{oss}$		-	1170	-	
Reverse transfer capacitance	$C_{rss}$		-	28	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=350\text{V}$ , $V_{GS}=10\text{V}$ , $I_D=20\text{A}$ , $R_G=5.7\Omega$	-	120	-	ns
Rise time	$t_r$		-	25	-	
Turn-off delay time	$t_{d(off)}$		-	140	210	
Fall time	$t_f$		-	30	45	

**Gate Charge Characteristics**

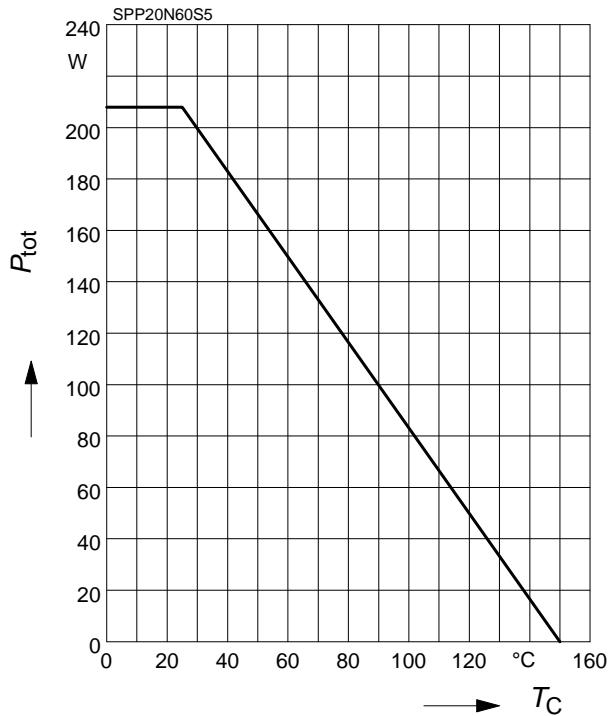
Gate to source charge	$Q_{gs}$	$V_{DD}=350\text{V}$ , $I_D=20\text{A}$	-	21	-	nC
Gate to drain charge	$Q_{gd}$		-	47	-	
Total gate charge	$Q_g$	$V_{DD}=350\text{V}$ , $I_D=20\text{A}$ , $V_{GS}=0$ to $10\text{V}$	-	79	103	

**Reverse Diode**

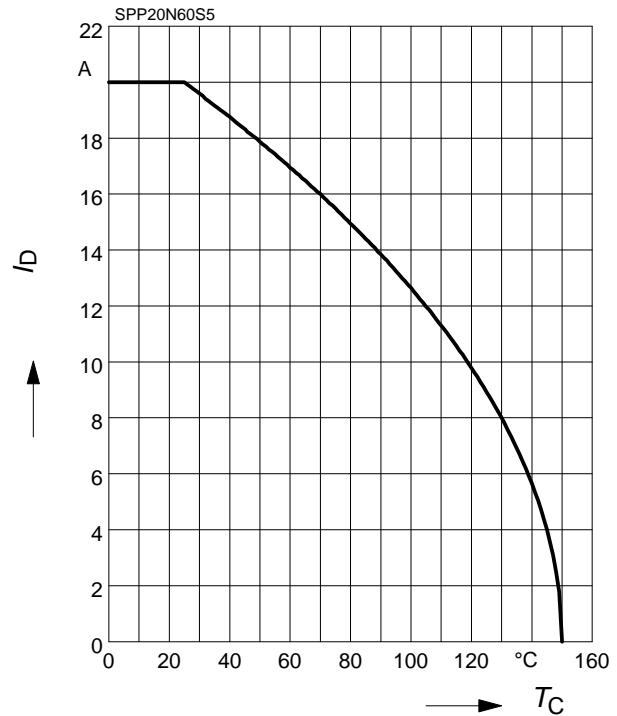
Inverse diode continuous forward current	$I_S$	$T_C=25^\circ\text{C}$	-	-	20	A
Inverse diode direct current,pulsed	$I_{SM}$		-	-	40	
Inverse diode forward voltage	$V_{SD}$	$V_{GS}=0\text{V}$ , $I_F=20\text{A}$	-	1	1.2	V
Reverse recovery time	$t_{rr}$	$V_R=100\text{V}$ , $I_F=I_S$ , $dI_F/dt=100\text{A}/\mu\text{s}$	-	610	-	ns
Reverse recovery charge	$Q_{rr}$		-	12	-	

**Power dissipation**

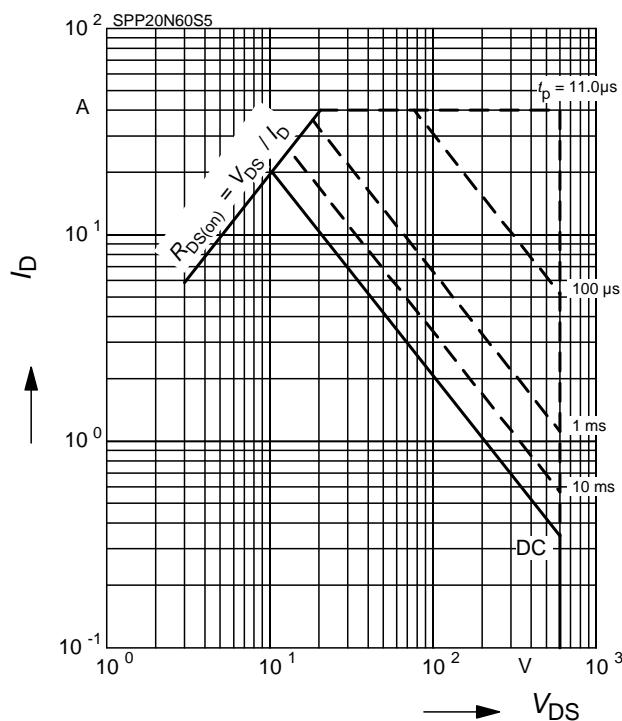
$$P_{\text{tot}} = f(T_C)$$


**Drain current**

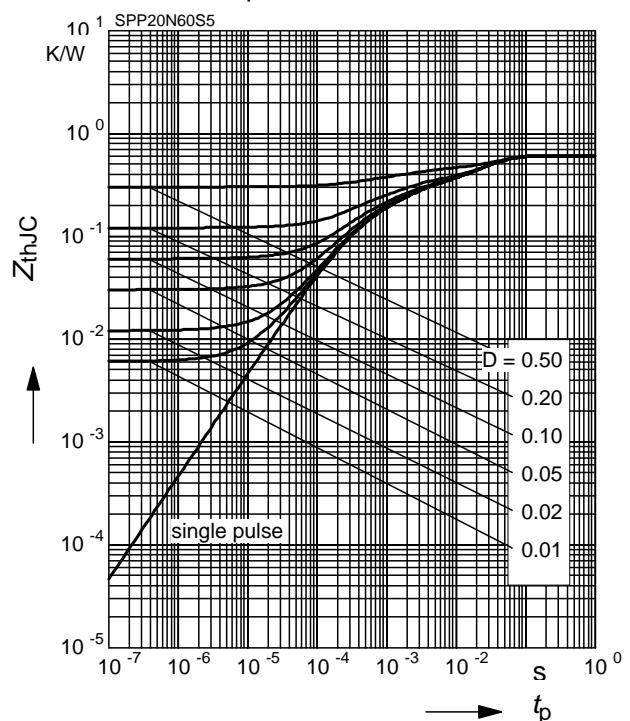
$$I_D = f(T_C)$$

 parameter:  $V_{GS} \geq 10 \text{ V}$ 

**Safe operating area**

$$I_D = f(V_{DS})$$

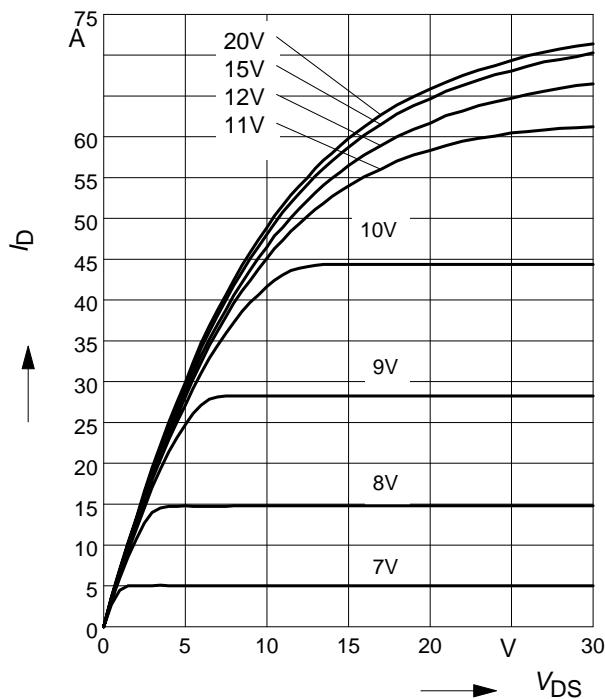
 parameter:  $D = 0.01, T_C = 25^\circ\text{C}$ 

**Transient thermal impedance**

$$Z_{\text{thJC}} = f(t_p)$$

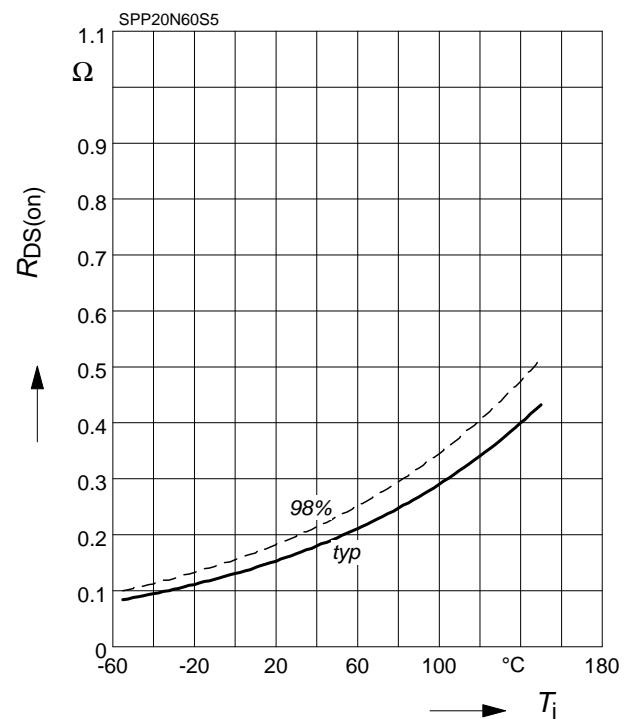
 parameter :  $D = t_p/T$ 


**Typ. output characteristic**

$$I_D = f(V_{DS})$$

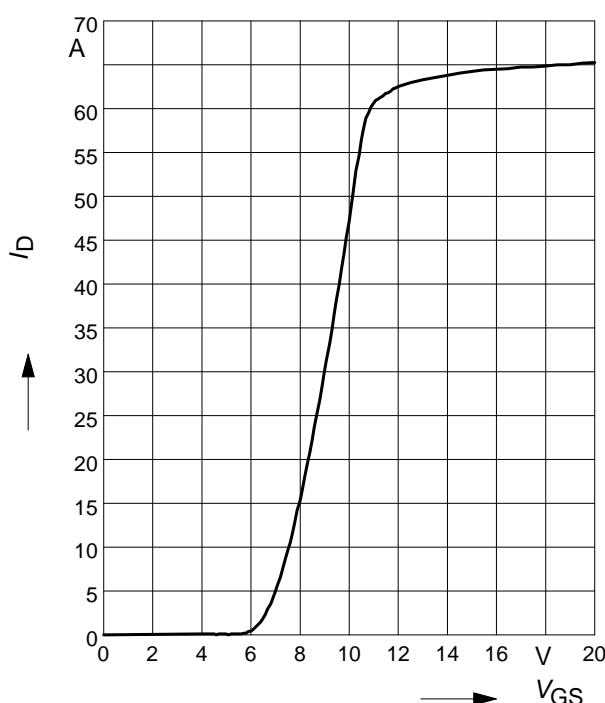
 Parameter:  $V_{GS}$ ,  $T_j = 25^\circ\text{C}$ 

**Drain-source on-resistance**

$$R_{DS(on)} = f(T_j)$$

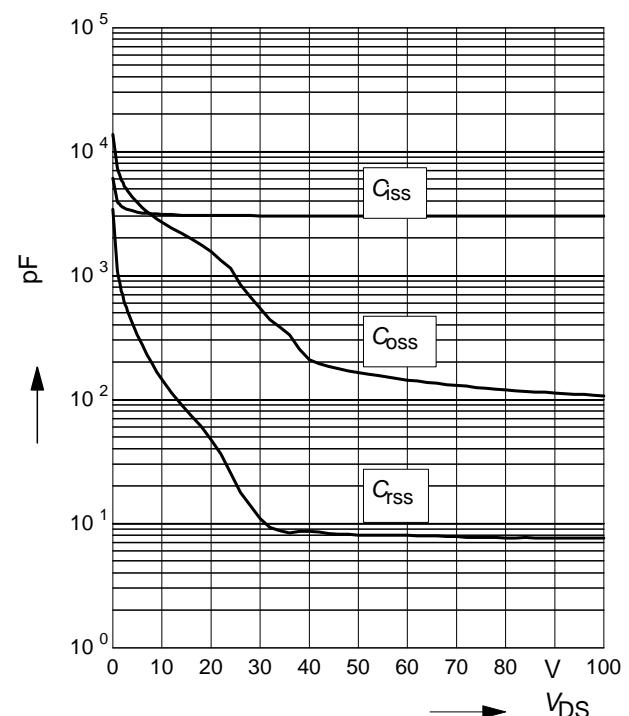
 parameter :  $I_D = 13 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$ 

**Typ. transfer characteristics**

$$I_D = f(V_{GS})$$

$$V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}$$

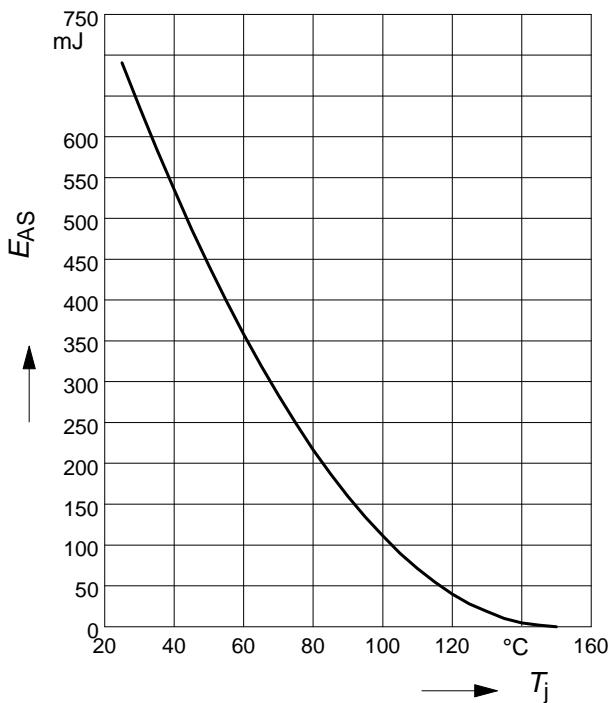

**Typ. capacitances**

$$C = f(V_{DS})$$

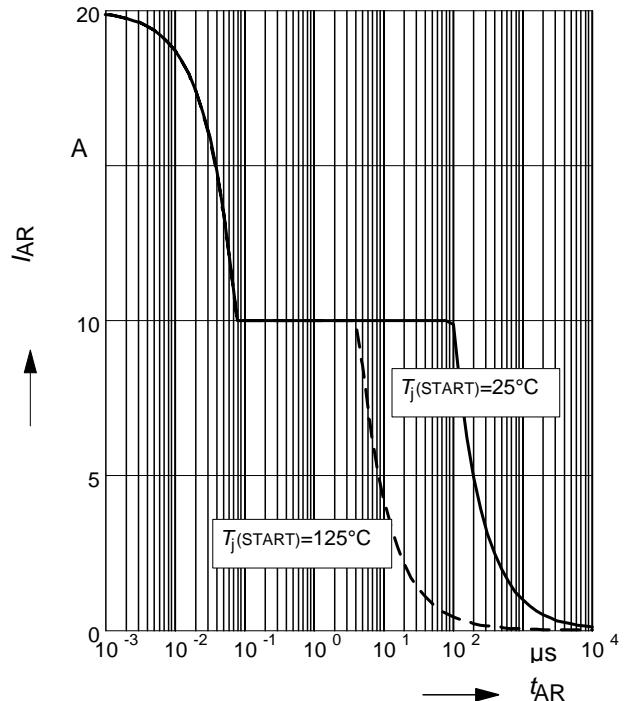
 parameter:  $V_{GS}=0 \text{ V}$ ,  $f=1 \text{ MHz}$ 


**Avalanche Energy**

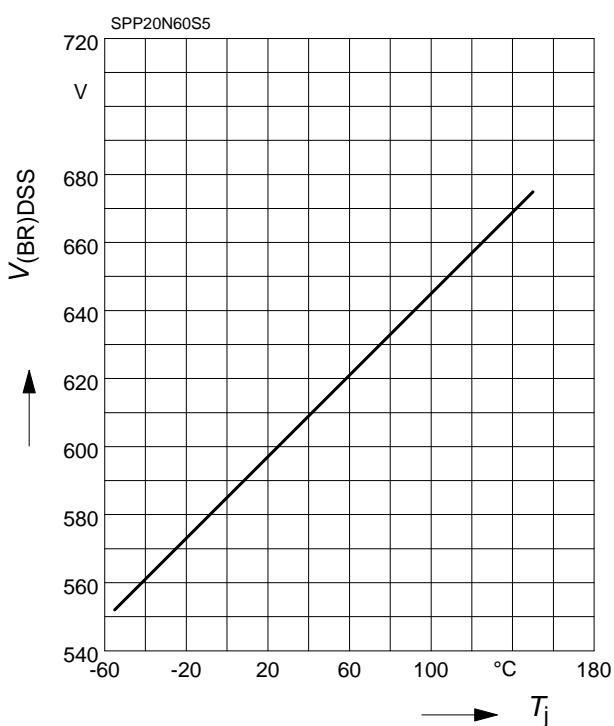
$$E_{AS} = f(T_j)$$

 par.:  $I_D = 10 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$ 

**Avalanche SOA**

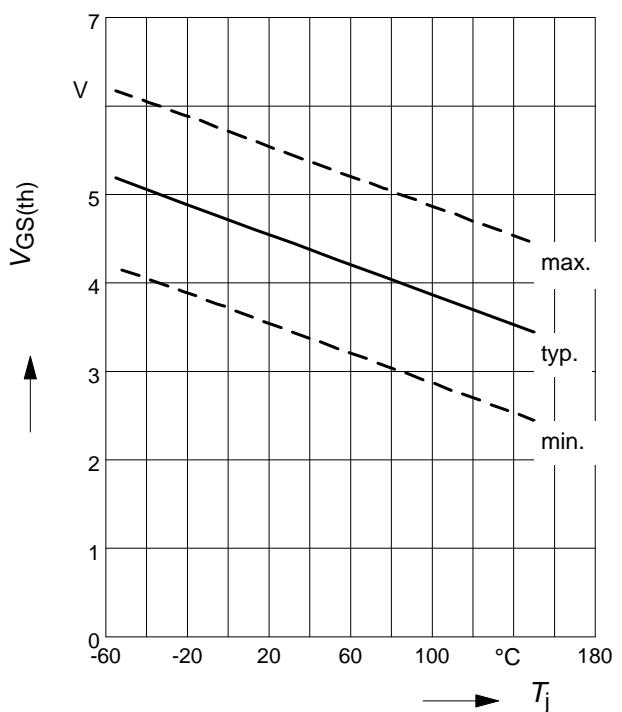
$$I_{AR} = f(t_{AR})$$

 par.:  $T_j \leq 150 \text{ °C}$ 

**Drain-source breakdown voltage**

$$V_{(BR)DSS} = f(T_j)$$

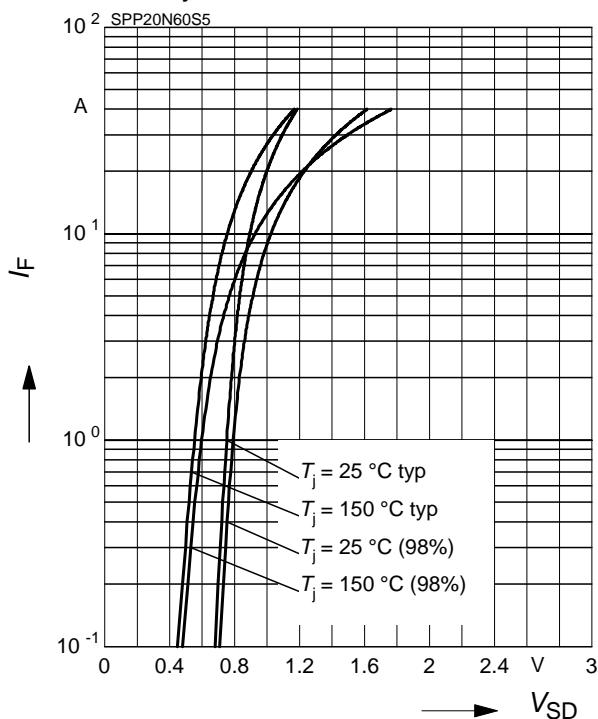

**Gate threshold voltage**

$$V_{GS(th)} = f(T_j)$$

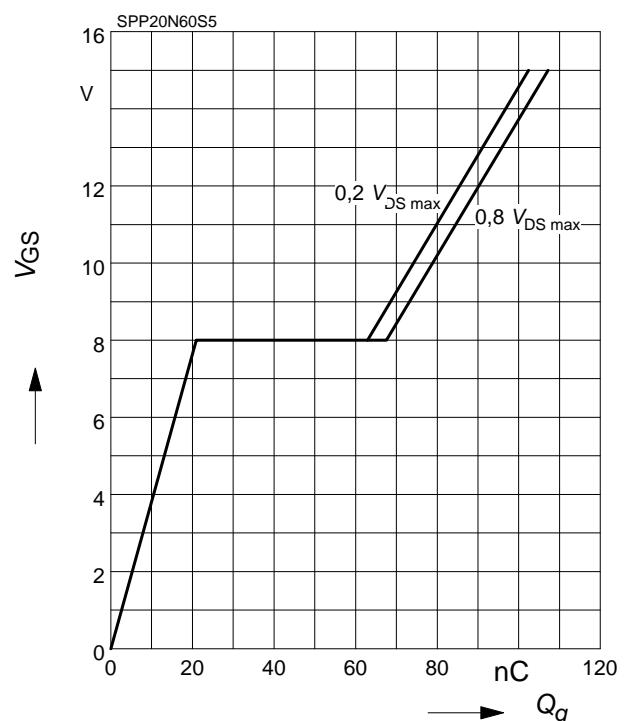
 parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1 \text{ mA}$ 


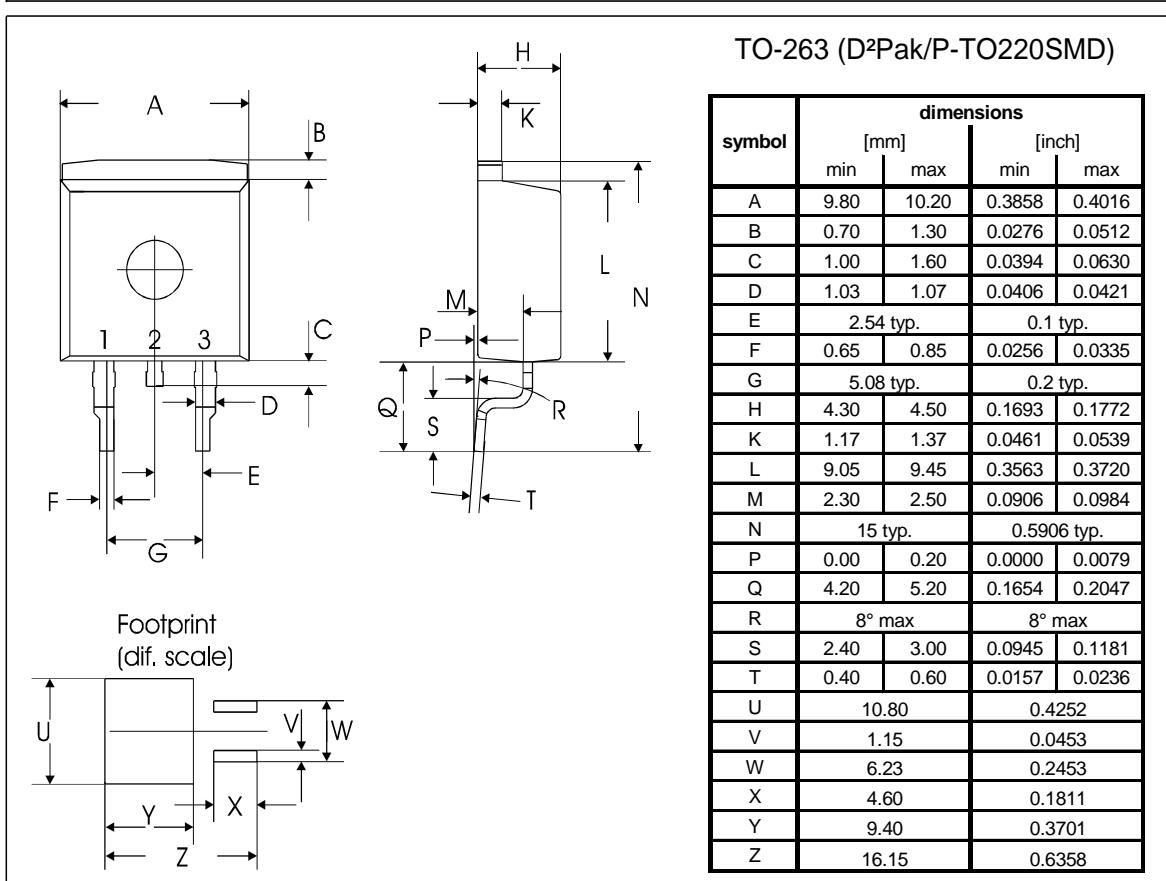
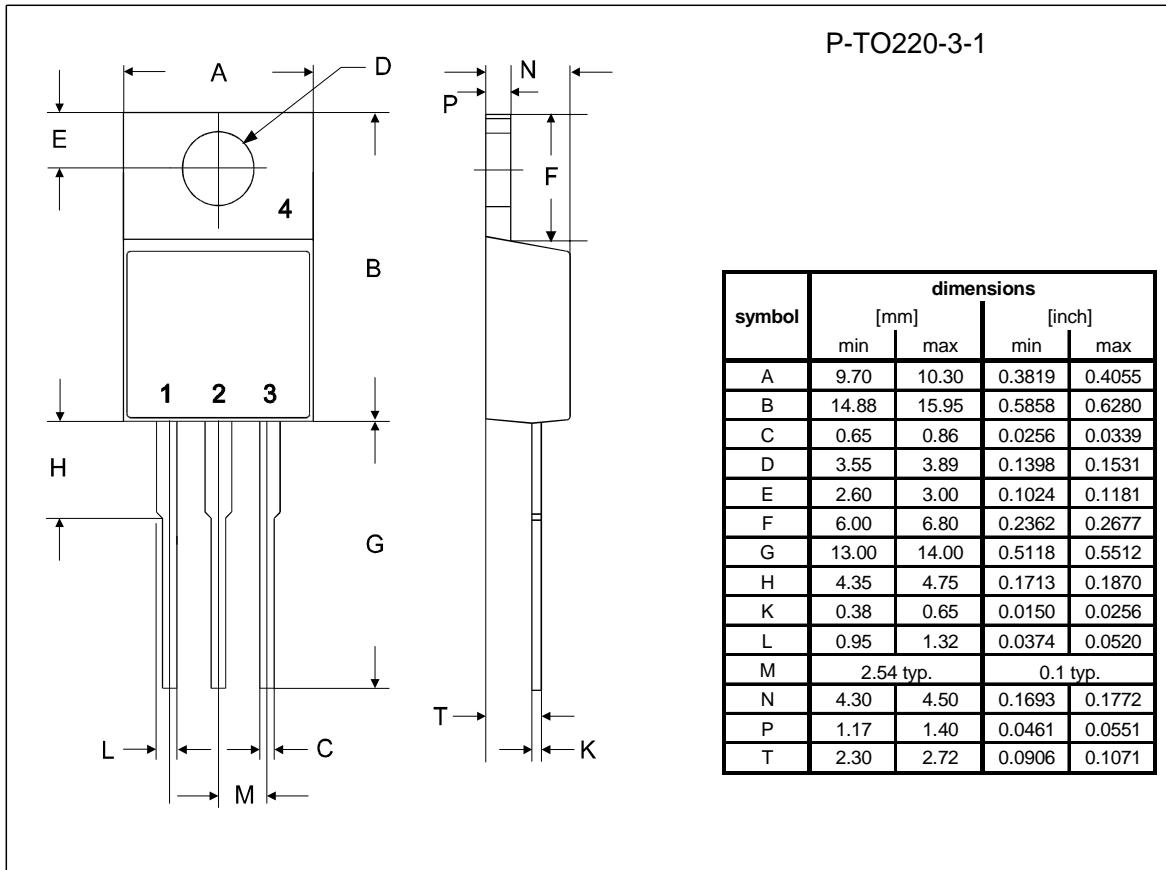
**Forward characteristics of reverse diode**

$$I_F = f(V_{SD})$$

 parameter:  $T_j$ ,  $t_p = 10 \mu\text{s}$ 

**Typ. gate charge**

$$V_{GS} = f(Q_{Gate})$$

 parameter:  $I_{Dpuls} = 20 \text{ A}$ 




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